

# Search Notes



Application/Control No.

10/531,788

Examiner

Sang Y. Paik

Applicant(s)/Patent under Reexamination

HAS, UWE

Art Unit

3742

## SEARCHED

Class	Subclass	Date	Examiner
219	445.1 446.1		
	448.11		
	448.12		
	480		
	482		
200	6A		
	11R		
	11A		
	18		
	120	3/17/06	18
4.1.1.1.2		12/14/00	4
		5/15/07	JP

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
First Test X600000	3/17/06	40